

IPC-A-610

Revision J – March 2024

Supersedes Revision H

September 2020

Acceptability of Electronic Assemblies

Developed by



BUILD ELECTRONICS BETTER

participants from

31 countries

contributed to this standard



IPC Mission

IPC is a global trade association dedicated to furthering the competitive excellence and financial success of its members, who are participants in the electronics industry.

In pursuit of these objectives, IPC will devote resources to management improvement and technology enhancement programs, the creation of relevant standards, protection of the environment, and pertinent government relations.

IPC encourages the active participation of all its members in these activities and commits to full cooperation with all related organizations.

About IPC Standards

IPC standards and publications are designed to serve the public interest through eliminating misunderstandings between manufacturers and purchasers, facilitating interchangeability and improvement of products, and assisting the purchaser in selecting and obtaining with minimum delay the proper product for their particular need. Existence of such IPC standards and publications shall not in any respect preclude any entity from manufacturing or selling products not conforming to such IPC standards and publication, nor shall the existence of such IPC standards and publications preclude their voluntary use.

IPC standards and publications are approved by IPC committees without regard to whether the IPC standards or publications may involve patents on articles, materials or processes. By such action, IPC does not assume any liability to any patent owner, nor does IPC assume any obligation whatsoever to parties adopting an IPC standard or publication. Users are wholly responsible for protecting themselves against all claims of liabilities for patent infringement.

IPC Position Statement on Specification Revision Change

The use and implementation of IPC standards and publications are voluntary and part of a relationship entered into by customer and supplier. When an IPC standard or publication is revised or amended, the use of the latest revision or amendment as part of an existing relationship is not automatic unless required by the contract. IPC recommends the use of the latest revision or amendment.

Standards Improvement Recommendations

IPC welcomes comments for improvements to any standard in its library. All comments will be provided to the appropriate committee.

If a change to technical content is requested, data to support the request is recommended. Technical comments to include new technologies or make changes to published requirements should be accompanied by technical data to support the request. This information will be used by the committee to resolve the comment.

To submit your comments, visit the IPC Status of Standardization page at www.ipc.org/status.



IPC-A-610J

Acceptability of Electronic Assemblies

If a conflict occurs
between the English
language and translated
versions of this document,
the English version will
take precedence.

Developed by the IPC-A-610 Task Group (7-31b), IPC-A-610 Task Group – Europe (7-31b-EU) and IPC-A-610 Task Group – China (7-31b-CN) of the Product Assurance Committee (7-30) of IPC

Supersedes:

IPC-A-610H – September 2020
IPC-A-610G – October 2017
IPC-A-610F WAM1 –
February 2016
IPC-A-610F – July 2014
IPC-A-610E – April 2010
IPC-A-610D – February 2005
IPC-A-610C – January 2000
IPC-A-610B – December 1994
IPC-A-610A – March 1990
IPC-A-610 – August 1983

Users of this publication are encouraged to participate in the development of future revisions.

Contact:

IPC
3000 Lakeside Drive, Suite 105N
Bannockburn, Illinois
60015-1249
Tel 847 615.7100
Fax 847 615.7105

Adoption Notices

www.ipc.org/ipc-document-revision-table

Acknowledgment

Any document involving a complex technology draws material from a vast number of sources across many continents. While the principal members of the IPC-A-610 Task Group (7-31b), IPC-A-610 Task Group – Europe (7-31b-EU) and IPC-A-610 Task Group – China (7-31b-CN) of the Product Assurance Committee (7-30) are shown below, it is not possible to include all of those who assisted in the evolution of this Standard. To each of them, the members of IPC extend their gratitude.

Product Assurance Committee

Chair

Robert Cooke
NASA Johnson Space Center

Vice Chair

Debbie Wade
Advanced Rework Technology Ltd.

IPC-A-610 Task Group (7-31b)

Co-Chairs

Symon Franklin
Custom Interconnect Ltd.
Tiberiu Baranyi
Flextronics Romania SRL

Vice Chair

Ekaterina Stees
Lockheed Martin Missiles & Fire Control

Technical Liaison of the IPC Board of Directors

Robert (Bob) Neves

Microtek Laboratories China

IPC-A-610 Task Group – Europe (7-31b-EU)

Chair

Debbie Wade
Advanced Rework Technology

IPC-A-610 Task Group – China (7-31b-CN)

Chair

Weng Feng
ZTE Corporation

Vice Chairs

Frank Geng
Jiangsu Simand Electronic Co., Ltd
Yabing Zou
5th Electronic Institute of MIIT

5-22A/7-31B Looks Like a Hangover A-Team

IPC recognizes the A-Teams for their exceptional leadership and effort in the development of this standard. IPC A-Teams are dedicated groups of volunteers who undertake a significant amount of work in standards development on behalf of their group.

A special thank you to the 5-22A/7-31B Looks Like a Hangover A-Team for their dedication and commitment to this effort. Their support and time during the development of this document is greatly appreciated.

Debbie Wade

Advanced Rework Technology

Jonathon Vermillion

Ball Aerospace & Technologies
Corp.*

Scott Meyer

Collins Aerospace

Timothy Pearson

Collins Aerospace

Symon Franklin

Custom Interconnect Ltd*

Tiberiu Baranyi

Flextronics Romania SRL*

Christina Rutherford

Honeywell Aerospace

Milea Kammer

Honeywell International*

Josh Goolsby

Lockheed Martin Missiles & Fire
Control

Kyle Johnson

Lockheed Martin Missiles & Fire
Control

Jarrold Webb

Lockheed Martin Missiles & Fire
Control*

Ekaterina Stees

Lockheed Martin-Missiles & Fire
Control*

Robert Cooke

NASA Johnson Space Center

Garry McGuire

NASA Marshall Space Flight
Center

Randy Bremner

Northrop Grumman

Thank you to the 7-31N-AT1 Sticky Squad for their efforts addressing the staking requirements.

Joseph E. Kane

BAE Systems

Tiberiu Baranyi

Flextronics Romania SRL

Tony Feldmeier

Honeywell Aerospace
Minneapolis*

Paul Zutter

U.S. Army Aviation & Missile
Command

Members of the IPC-A-610 Task Group

Alejandro Alvarado Castaneda	Yelda Yucel	Jodi Johnson
Moriah Bischann	Aselsan Electronic Ind. Inc.	BEST Inc.
Charles Daniel	Robert Courtenay	Norman Mier
Jeremy Hamilton	Astranis Space Technologies Corp.	BEST Inc.
Kohei Hayashi	Rob Mullane	Kris Roberson
Kurt McLain	Atek Training Services Ltd.	BEST Inc.
Sean McNair	Paul Klein	Samuel Sorto
Lynn Rozanski	ATRON Group LLC	Blue Origin, LLC
Akio Saito	Steve Wright	David Lee
Christian Schellenschlager	ATRON Group LLC	BMK Professional Electronics GmbH
Kevin Schuld	Kang Ren	Kevin Caruso
Hank Stetter	AVIC Xi'an Aeronautics	Boeing
Lorna Stoddart	Computing Technique Research Institute	Chris Bender
Toshiyuki Sugiyama	Jia Liang	Boeing – Integrated Defense Systems
Chester Terrill	AVIC TaiYuan Aero-Instruments Co., Ltd.	Eric Harenburg
Teagan Brendlinger	Mathew Williams	Boeing Company
3DFortify Inc	Axis Electronics Ltd.	Wang Yueyin
Neil Wolford	Erik Bjerke	BSH Electrical Appliances (Jiangsu) Co., Ltd
AbelConn, LLC	BAE Systems	Johnson Muriel
Constantino Gonzalez	David Fellows	BTE Training & Electronics PLT
ACME Training & Consulting	BAE Systems	Jason Fullerton
Pietro Vergine	Tim Gallagher	CAES
Advanced Rework Technology	BAE Systems	Angel Deluna
John Vickers	Joseph Kane	Circuit Technology Inc.
Advanced Rework Technology	BAE Systems	Robert Priore
Debbie Wade	Maan Kokash	Cisco Systems Inc.
Advanced Rework Technology	BAE Systems	Colette Anctil
Annemarie Popik	Agnieszka Ozarowski	Collins Aerospace
AFRL	BAE Systems	Wendell Brockman
Yuji Kondo	Marie Parliman	Collins Aerospace
Aisin Seiki Co. Ltd.	BAE Systems	William Cardinal
Gail Fukumoto	Paul Sargent	Collins Aerospace
Amazon Lab126	BAE Systems	Dan Ezenekwe
Joseph Stanley	Logan Johnson	Collins Aerospace
Amazon Project Kuiper	BAE Systems, Inc.	Scott Meyer
Leo Huang	Tyler Schlueter	Collins Aerospace
APCB Electronics (KunShan) Co., Ltd.	BAE Systems, Inc.	Jason Nipper
Sean Keating	Dan White	Collins Aerospace
Amphenol Ltd (UK)	BAE Systems, Inc.	Douglas Pauls
Stefan Hanigk	George Tristan	Collins Aerospace
Ariane Group GmbH	Ball Aerospace & Technologies Corp.	Timothy Pearson
Battal Acar	Jonathon Vermillion	Collins Aerospace
Aselsan Electronic Ind. Inc.	Ball Aerospace & Technologies Corp.	Titus Rumph
Sertac Caglarca	Gerald Bogert	Collins Aerospace
Aselsan Electronic Ind. Inc.	Bechtel Plant Machinery, Inc.	Debie Vorwald
Serkan Ozturk	Jenny Lee	Collins Aerospace
Aselsan Electronic Ind. Inc.	Beijing Hangxing Technology Development Co.	Andrew Giamis
Zehra Ceren Tunal		Commscope
Aselsan Electronic Ind. Inc.		Marilyn Lawrence
		Conformance Technologies, Inc.

Miguel Dominguez Continental Automotive	Jorien van Ommen Faber Electronics BV	Ryan Eatinger Honeywell FM&T
Ignacio Gaeta Continental Automotive Guadalajara Mexico S.A. de C.V.	Hongfei Zhou Flextronics Power Systems (Dongguan) Co., Ltd.	Louis Diamond Honeywell FM&T
Sabin Mihai Ciucean Continental Automotive Systems, S.R.L.	Tiberiu Baranyi Flextronics Romania SRL	Milea Kammer Honeywell International
Guangxiang Lu Continental Holding China	Dan Mihai Dita Flextronics Romania SRL	Jennie Hwang H-Technologies Group
Danqing Wen CSIC Xian Dong Yi Science Technology & Industry Group Co., Ltd	Harald Olsen FMC Technologies AS	Poul Juul HYTEK
Symon Franklin Custom Interconnect Ltd	Eric Camden Foresite, Inc.	Daniel Versluis HYTEK
Ryder Gao CVTE	Deogenes Papelera Fresenius Kabi	Lorraine Spencer i3 Electronics, Inc.
Irene Romero Delta Group Electronics Inc.	Henrik Blegvad Jensen Gaasdal Bygningsindustri A/S	Sarah Kolak IBM Corporation
James Sinclair Dexta Moors LTD	Jodie Fallen GE Aviation Systems	Abby Wise IBM Corporation
Cengiz Oztunc DNZ Ltd.	Karen Perry GE Aviation Systems, Ltd.	Jonathan Albrieux IFTEC
Blake Singh Druck Limited	Christopher Hunt GEN3	Robert Bowden Impact Centre for Training & Staffing
Adam Fidura Dyson Technology Limited	Olivia Leija Gentherm Texas	Richard Josselyn Impact Centre for Training & Staffing
Constantin Hudon East West Quebec	Michele Campi GESTLABS S.r.l.	Benoit Dagenais Innovative Vehicle Institute
Mark Hood EEI Manufacturing Services	Francesco Di Maio GESTLABS S.r.l.	Ife Hsu Intel Corporation
Karen Smalls EEI Manufacturing Services	Adam Bland Globalstar	Jeffrey Black Intervala, LLC
Yaakov Zissman Elta Systems Ltd.	Michael Ceraso Globalstar	Jeffrey Lee iST – Integrated Service Technology
Emma Hudson Emma Hudson Technical Consultancy Ltd	Claus Molgaard GN Hearing A/S	Mirko Giannecchini Istituto Italiano della Saldatura – Legnano
Leo Lambert EPTAC LLC	Young Ho Hwang Guru E&E Inc.	Stefano Barbieri Istituto Italiano della Saldatura – ROME
Marcia McLaughlin EPTAC LLC	Torsten Schmidt HELLA GmbH & Co. KGaA	Matteo Senzioni Istituto Italiano della Saldatura – ROME
Helena Pasquito EPTAC LLC	David Hillman Hillman Electronic Assembly Solutions LLC	Arphitha Namchoksamrit Jabil Circuit (Shanghai) Ltd.
Ramon Essers ETECH Training	Paul Gough Honeywell Aerospace	Kimura Akinori Japan Aviation Electronics Industry, Limited
John O'Neill ETECH Training	John Mastorides Honeywell Aerospace	Hideyuki Arakane Japan Unix Co., Ltd.
Iain McMillan Exmel Solutions Ltd	Christina Rutherford Honeywell Aerospace	Mitsuhiro Asaka Japan Unix Co., Ltd.
John Thuss Faber Electronics BV	Keith Walker Honeywell Aerospace	Tatsuya Chiba Japan Unix Co., Ltd.
	Tony Feldmeier Honeywell Aerospace Minneapolis	
	Richard Rumas Honeywell Canada	

Toshiyasu Takei Japan Unix Co., Ltd.	Bradley Toone L3 Harris Technologies Communication Systems – West	Matthew Millican Lockheed Martin Missiles & Fire Control
Tsutomu Suzuki Japan Unix Co., Ltd.	Jared Spencer L3 Harris Technologies Communication Systems – West	Sean Mullen Lockheed Martin Missiles & Fire Control
Minako Takahashi Japan Unix Co., Ltd.	Greg Number L3Harris	Owen Reid Lockheed Martin Missiles & Fire Control
Oscar Alcala Jet Propulsion Laboratory	Corey Hinnerger L3Harris Technologies, Inc.	Daniel Schultz Lockheed Martin Missiles & Fire Control
Katina Celio Jet Propulsion Laboratory	Jamie Zhou LCFC (HeFei) Electronics Technology Co., Ltd.	Tyler Siebert Lockheed Martin Missiles & Fire Control
Rachel Hartig Johns Hopkins University	Keld Maaloe LEGO Systems A/S	Ekaterina Stees Lockheed Martin Missiles & Fire Control
Matthew Krok Johns Hopkins University	Antonio Perna Leonardo	Danielle Thompson Lockheed Martin Missiles & Fire Control
Mingye Wang Junfeng Electronics Control Technology Dalian Co., Ltd.	Rebekah Kovarik Lockheed Martin	Ann Marie Tully Lockheed Martin Missiles & Fire Control
Kevin Boblits K&M Manufacturing Solutions, LLC	Mark Duncan Lockheed Martin Corporation	Lucas Walsh Cochran Lockheed Martin Missiles & Fire Control
Latha M.S Kaynes Technology India Pvt. Ltd	Haberly Kahn Lockheed Martin Corporation	Andrew Wancheck Lockheed Martin Missiles & Fire Control
Kim Souva Kearfott Corporation	David Caputa Lockheed Martin Corporation	Jarrold Webb Lockheed Martin Missiles & Fire Control
Stephanie Bren Killdeer Mountain Manufacturing, Inc.	Jacynth Anderson Lockheed Martin Missiles & Fire Control	Oscar Vera Lockheed Martin Missiles & Fire Control
Aaron Zhou Kitron Electronics Manufacturing (Ningbo) Co.	Javier Caraccioli Lockheed Martin Missiles & Fire Control	Elizabeth Yount Lockheed Martin Missiles & Fire Control
Jasbir Bath Koki Solder America	Diana Dunman Lockheed Martin Missiles & Fire Control	Maya Chiesa Lockheed Martin Mission Systems & Training
Minsu Lee Korea Packaging Integration Association	Josh Goolsby Lockheed Martin Missiles & Fire Control	David Mitchell Lockheed Martin Mission Systems & Training
Ji Hun Park Kyungshin Cable Co., Ltd.	Ben Gumpert Lockheed Martin Missiles & Fire Control	Tom Rovere Lockheed Martin Mission Systems & Training
Sea June O Kyungshin Cable Co., Ltd.	Joshua Hudson Lockheed Martin Missiles & Fire Control	Kimberly Shields Lockheed Martin Rotary and Mission Systems
Jae Mo Lee Kyungshin Cable Co., Ltd.	Sharissa Johns Lockheed Martin Missiles & Fire Control	Chad Derrick Lockheed Martin Space Systems Company
Mike Bixenman Kyzen Corporation	Kyle Johnson Lockheed Martin Missiles & Fire Control	
Augustin Stan L&G Advice Serv SRL	Nathan Knipe Lockheed Martin Missiles & Fire Control	
William Fish L3 Harris Technologies Communication Systems – West	Vijay Kumar Lockheed Martin Missiles & Fire Control	
Shelley Holt L3 Harris Technologies Communication Systems – West		
Jefferson Thomas L3 Harris Technologies Communication Systems – West		

Mary Phillips Lockheed Martin Space Systems Company	Christina Landon Naval Surface Warfare Ctr	Amanda VanHoesen Northrop Grumman North Dakota
Paul Kirpes Los Alamos National Laboratory	Hiroaki Kondo NEC Platforms Ltd.	Brandon Davis Northrop Grumman Space Systems
Linda Woody LWC Consulting	Tsuyoshi Nagasawa NEC Platforms Ltd.	Mahendra Gandhi Northrop Grumman Space Systems
Mary Muller MK Muller Consulting LLC	Satish V P Neuro Technology Middle East Fze	Callie Olague Northrop Grumman Systems Corporation
David Torp Mechnano	Randy Bremner Northrop Grumman	William Graver NTS – Baltimore
Olaf Nennewitz Mercedes-Benz AG	Jeff Cutter Northrop Grumman	Ken Moore Omni Training Corp.
Robert (Bob) Neves Microtek Laboratories China	Steven Davis Northrop Grumman	Hans Shin Pacific Testing Laboratories, Inc.
William Pffingston Miraco, Inc.	Claire Dvorak Northrop Grumman	Hisao Ihuri Panasonic
Fernando Haller Mirgor Group	Connor Meeds Northrop Grumman	Hiroyuki Akiyama Panasonic Corporation
Daniel Foster Missile Defense Agency (MDA)	Stephanie Stork Northrop Grumman	Gustavo Arredondo PARA TECH Parylene Services
Keith Peterson Missile Defense Agency (MDA)	James Windgassen Northrop Grumman	Wim Bodelier PIEK International Education Centre (I.E.C.) BV
Matthew Thomas Missile Defense Agency (MDA)	Matthew Edwards Northrop Grumman Corp.	Ron Fonsaer PIEK International Education Centre (I.E.C.) BV
Dominic Field Moog Inc.	Alexa Fisher Northrop Grumman Corporation	Frank Huijsmans PIEK International Education Centre (I.E.C.) BV
Michael Cochran Moog Inc.	Mike Morris Northrop Grumman Corporation	Kirk Van Dreel Plexus Corporation
Edward Rios Motorola Solutions	Kevin Mull Northrop Grumman Corporation	Zachary Quick Quick Turn Training and Consulting LLC
Eric Borrero NASA Goddard Space Flight Center	Carlo Viola Northrop Grumman Corporation	William Bear Raytheon Company
Alvin Boutte NASA Goddard Space Flight Center	Colin Williams Northrop Grumman Corporation	James Daggett Raytheon Company
Chris Fitzgerald NASA Goddard Space Flight Center	Nicholas Wilson Northrop Grumman Corporation	Shawn Downey Raytheon Company
Bhanu Sood NASA Goddard Space Flight Center	Steven Pieszala Northrop Grumman ESSD	Lisa Maciolek Raytheon Company
Robert Cooke NASA Johnson Space Center	Benjamin Hall Northrop Grumman Innovation Systems	Fonda Wu Raytheon Company
Diego Gomez Ruiz NASA Marshall Space Flight Center	Patrick Phillips Northrop Grumman Innovation Systems	Lance Brack Raytheon Missile Systems
Adam Gowan NASA Marshall Space Flight Center	Ceferino Reyes Northrop Grumman Innovation Systems	Maria Colon Raytheon Missile Systems
Garry McGuire NASA Marshall Space Flight Center	Mark Terranova Northrop Grumman Innovation Systems	Cathi Miles Raytheon Missile Systems
	Robert Barnes Northrop Grumman North Dakota	George Millman Raytheon Missile Systems

Andrew Rodack Raytheon Missile Systems	Marcus Richardson Spartronics	Christopher Meyers Tobyhanna Army Depot
Nichole C. Thilges Raytheon Missile Systems	Jeffery Smith Spartronics	Michael Rosencranz Tobyhanna Army Depot
Alfonso Bartee Raytheon Systems Company	Lamar Young Specialty Coating Systems Inc.	Norihito Suzuki Tokai Rika Co., Ltd.
Pascal Dumontet Renault	Robert Fornefeld STI Electronics, Inc.	Hisao Nishimori Toyota Motor Corporation
Marcin Sudomir Renex Electronics Education Center	Frank Honyotski STI Electronics, Inc.	Fuji Jun Wu Toyota Motor Corporation
Lothar Henneken Robert Bosch GmbH	Mark McMeen STI Electronics, Inc.	Gaston Hidalgo Toyota Motor North America
Udo Welzel Robert Bosch GmbH	Patricia Scott STI Electronics, Inc.	Thomas Ahrens Trainalytics GmbH
James Jones Rocket Lab USA Inc	Meagen Stone STI Electronics, Inc.	Gary DiBlanda Triumph Engine Control Systems
Jessica Jacobs Rockwell Collins	Elena Yosifova Straschu Industrie-Elektronik GmbH	Cherry Yin TT electronic integrated manufacturing services (Suzhou) Limited
Christina Badour Ross Video Ltd.	Kevin Tlaxcalteca Summit Interconnect – Orange	Joshua Keene TTM – Denver East
Steven Roy Roy Design and Manufacturing Service	Alex Johnston Sundown Aerospace, LLC	Gerald Palmer TTM – Denver East
Casimir Budzinski Safari Circuits Inc.	Chen Qin Suzhou Eunow Company Limited	Nick Koop TTM Technologies
Laura Budzinski Safari Circuits Inc.	Daigo Ichikawa Tamura Kaken Co. Ltd.	Paige Fiet TTM Technologies – Logan Division
John Tickle Safran Electronics & Defense Canada Inc.	Harlan Wu TE Connectivity	Harry Craft TTM Technologies, Inc.
Gary Latta SAIC	Arbi Zaied TEAM Partner	Daniel Koss TTM Technologies, Inc.
Ryan Clark Samsung Austin Semiconductor	Brian Crowell Tech-Etch Inc.	Vicki Hilliard U.S. Army Aviation & Missile Command
Rodney Doss Samtec, Inc.	Tracy Clancy Vecchiolli Technical Training Center	Paul Zutter U.S. Army Aviation & Missile Command
Teddy Vigil Sandia National Labs Albuquerque	Marino Verderio Technoprobe S.p.A.	Steven Dirkes-Gomez U.S. Army Sustainment Command
Ross Dillman Sechan Electronics Inc.	Michael Collier Teledyne Advanced Electronic Solutions	Crystal Vanderpan UL LLC
Lin Cao Shenyang Railway Signal Co., Ltd.	Donald Tyler Ten Eyck Group, LLC	Barrie Dunn University of Portsmouth
Jeremy Lakoskey Sierra Space	Hannah Nelson Texas Instruments	Rachel Grinvalds UTC Aerospace
Makoto Aitani SIIX Electronics Co., Ltd.	Steven Neff Textron Systems (AAI)	Luis Soto UTC Aerospace Systems
Gerard O'Brien Solderability Testing & Solutions, Inc.	James Parke The Aerospace Corporation	Jack (Jian) Zhu Veoneer China Co., Ltd
Scott Vorhies Space Exploration Technologies	Amber Perez The Aerospace Corporation	Kaan Garpli Vestel Elektronik A.S.
Nicholas Hudson Spartronics	Claire French The Electronics Group Ltd.	
	Malcolm Longley The Electronics Group Ltd.	

Dave Harrell Viasat Inc.	Luis Dias West Control Solutions	Zhiman Chen ZhuZhou CRRC Times Electric Co., Ltd.
Jose Servin Olivares Vitesco Technologies	Scott Raszeja Z Engineering	Renee Hallahan Zoll Medical Corp.
Hans-Otto Fickenschner Vitesco Technologies Germany GmbH	Michael Seltzer Zentech Manufacturing	Fugang Nie ZTE Corporation

REGIONAL GROUPS

Members of IPC-A-610 Task Group – Europe (7-31b-EU)

Debbie Wade Advanced Rework Technology**	Tiberiu Baranyi Flextronics Romania SRL**	Keld Maaloe LEGO Systems A/S
John Vickers Advanced Rework Technology	Harald Olsen FMC Technologies AS	Antonio Perna Leonardo
Pietro Vergine Advanced Rework Technology	Henrik Blegvad Jensen Gaasdal Bygningsindustri A/S	Piotr Armata Murata Power Solutions
Stefan Hanigk Ariane Group GmbH	Francesco Di Maio GESTLABS S.r.l.	Torgrim Nordhus Norautron AS
Rob Mullane Atek Training Services Ltd.	Claus Molgaard GN Hearing A/S	Rob Walls PIEK International Education Centre (I.E.C.) BV
Gianluca Parodi Cistelaier SpA	Alex Christensen HYTEK	Pascal Dumontet Renault
Andreas Gregor Consultronica, S.L.	Jonathan Albrieux IFTEC	Elena Yosifova Straschu Industrie-Elektronik GmbH
Sabin Mihai Ciucean Continental Automotive Systems, S.R.L.	Mirko Giannechini Istituto Italiano della Saldatura – Legnano	Marino Verderio Technoprobe S.p.A.
Symon Franklin Custom Interconnect Ltd	Matteo Senzioni Istituto Italiano della Saldatura – ROME	Thomas Ahrens Trainalytics GmbH
Adam Fidura Dyson Technology Limited	Stefano Barbieri Istituto Italiano della Saldatura – ROME	Luis Dias West Control Solutions
John O'Neill ETECH Training	Augustin Stan L&G Advice Serv SRL	
Iain McMillan Exmel Solutions Ltd		

Members of IPC-A-610 Task Group – China (7-31b-CN)

Shun Zhang	Kunbin Huang APCB Electronics (KunShan) Co., Ltd.	Kang Ren AVIC Xi'an Aeronautics Computing Technique Research Institute**
David Yao	Weidong Yao APTIV Electronics (Suzhou) Co., Ltd	Jia Liang AVIC TaiYuan Aero-Instruments Co., Ltd.
Chen Peng	Shanli Wang Askey Technology (Jiangsu) Co. Ltd.	Ying Guo Avic Xi'an Flight Automatic Control Research Institute
June Xu	Tianxiang Wang Askey Technology (Jiangsu) Co. Ltd.	Alan (Menghua) Sun BCS Automotive Interface Solutions (Suzhou) Co., Ltd.
Zhaozhan Qiu	Jacky (Chaofeng) Zhao Autoliv Shanghai	Jie He Beijing BRIO Electronic Technologies Ltd.
Yuqing Yao		
Nancy Lu		
Pinghua Duan		
Shuai Yin Amazon Lab126		
Leo Huang APCB Electronics (KunShan) Co., Ltd.		

Jenny Lee Beijing Hangxing Technology Development Co.	Xuyao Yang JARI Electronics Co., Ltd.	Hongzhou Zhou SCUD (Fujian) Electronics Co., Ltd.
Glory (Guoliang) Yin Beijing Hangxing Technology Development Co., Ltd.	Ming Geng Jiangsu Simand Electric Co., Ltd	Ping Zhao Shaanxi Fenghuo Electronics Co., Ltd
Lixiang Lin BizLink Holding Inc. Xiang Yao Electronics (Shenzhen) Co., Ltd.	Eileen Xiang Kimball Electronics (Nanjing) Co., Ltd.	Roger Ji Shanghai Hugong Auto-electric CO., LTD.
Wang Yueyin BSH Electrical Appliances (Jiangsu) Co., Ltd	Stuart Chang Kitron Electronics Manufacturing (Ningbo) Co.	Jie Yuan Shanghai Quickturn Electronics Co., Ltd.
Xiaochun Zhou Celestica (Suzhou) Technology Co. Ltd.	Aaron Zhou Kitron Electronics Manufacturing (Ningbo) Co.	Jiong (Crystal) Dai Shennan Circuits Co. Ltd.
Jie Chen Chengdu Yaguang Electronics Co., Ltd.	Vincent Lei Lenovo ISG	Chengyan Cui Shenyang Railway Signal Co., Ltd.
Meng Fei China Aeronautical Radio Electronics Research Inst	Gao Hu Lianyungang JARIE Electronics Co., Ltd	Baidong Li Shenyang Railway Signal Co., Ltd.
Xue Yong Li Computime Electronics (Shenzhen) Company Limited	Xian Lv Magnet Marelli Automotive Electronics (Guangzhou) Co., Ltd	Johnson (Songtao) Zhao ShenZhen Easyway Science & Technology Co. Ltd.
Hongyun Wang Computime Electronics (Shenzhen) Company Limited	Tommy Zhang Marelli Automotive Parts Co. Ltd.	Xianhua Tang Shenzhen HanShine Technology Co., Ltd
Guangxiang Lu Continental Holding China	Zheng Qu Marquardt Switches (Weihai) Co., Ltd.	Li Anan Shenzhen Kinwong Electronic Co., Ltd.
Lina Zhao CRRC Tangshan Co., LTD.	Zhimin Zhang Maxway Technology Co., Ltd	Lin Xu Shenzhen Mindray Bio-Medical Electronics Co., LTD
Yangchun Zhang Dongguan Shin Tech Limited	Feng Xueliang Meixin Testing Technology Co., Ltd	Haiquan (Allan) Shi SION International
Arlene Liu Eolane (China) Co., Ltd.	Zhi Wang Mindray Medical International Limited	Kiet Le Spitfire Controls (Vietnam) Co., Ltd.
Mei Yang Flex	Rex Chang Molex Taiwan Ltd. Sanchong Branch	Chen Qin Suzhou Eunow Company Limited
Hua Mei Flextronics Electronics Technology (Suzhou) Co. Ltd.	Qingguo Chen National Center of Quality Supervision and Testing for Printed Circuit Board (AnHui)	Leif Xu Suzhou Faithful Electronics Co., Ltd
Batter Shen Flextronics Electronics Technology (Suzhou) Co. Ltd.	Qiuju Yan Ningbo CRRC Times Transducer Technology Co., Ltd	David Zhang Suzhou Inovance Automotive Co., Ltd.
Yunxue Li Geely University of China	Zhu Claud Nokia Shanghai Bell Co., Ltd.	Qibin Liu TE Connectivity Sensor Solutions
Chengbo Zhang ITW Specialty Materials Suzhou Co., Ltd.	Haixing Zhang P.C.B.A Electronic (WuXi) Ltd.	Yabing Zou The 5th Electronic Institute of MIIT**
Joe Zhong Jabil Circuit (Guangzhou) Ltd.	Leijin Tao Plastic Omnium Lighting Systems (Kunshan) Co., Ltd	Jack (Jian) Zhu Veoneer China Co., Ltd***
Huifang Lan Jabil Circuit (Guangzhou) Ltd.	Jinkui Zhu QingDao Coreda Intelligent Electric Co., Ltd.	Damny Lu Weimeng Electronic Kunshan Co. Ltd.
Min Tang Jabil Circuit (Shanghai) Ltd.		

Jayne Lai Wistron InfoComm (Zhongshan) Corp.	Feng Zhou ZhuZhou CRRC Times Electric Co., Ltd.	Zhongzhong Jia ZTE Corporation
Ricky Sun ZF Automotive Components (Shanghai) CO., Ltd.	Xianghu Pan Zhuzhou CRRC Times Electric Co., LTD.	Huasheng Qium ZTE Corporation Yu Wang ZTE Corporation

* Leader of the A-Team at the time this document was published.

** Cochair of the regional group at the time this document was published.

*** Vice Chair of the regional group at the time this document was published.

Figures 4-39, 4-40, 6-24, 6-56, 8-136, 9-32, and 10-75 are
Image Credit: NASA, used by permission.

Figures 5-51, 5-53, 6-37, 8-53, 8-60, 8-154, 8-155, 8-156,
8-157, 8-158, 8-159 are © Bob Willis, used by
permission.

Figures 4-13, 5-19, 5-22, 5-27, 5-42, 5-43, 6-21, 6-23,
6-26, 6-41, 6-60, 6-61, 6-65, 6-66, 6-67, 6-76, 6-77,
6-84, 6-89, 6-90, 6-91, 6-94, 6-95, 6-96, 6-97, 6-99,
6-100, 6-101, 6-102, 6-106, 6-108, 7-11, 7-16, 7-25,
7-29, 7-74, 7-82, 8-161, A-3, A-4 are © Omni Training,
used by permission.

*In memory of Jim Blanche, NASA Marshall Space Flight Center
and Kathy L. Johnston, Raytheon Missile Systems (retired)*

This Page Intentionally Left Blank

Table of Contents

1.0	General	1-1
1.1	Scope	1-1
1.2	Purpose	1-2
1.3	Classification	1-2
1.4	Measurement Units and Applications	1-2
1.4.1	Verification of Dimensions	1-2
1.5	Requirements	1-2
1.5.1	Acceptance Criteria	1-3
1.5.1.1	Acceptable	1-3
1.5.1.2	Defect	1-3
1.5.1.2.1	Disposition	1-3
1.5.1.3	Process Indicator	1-3
1.5.1.4	Conditions Not Specified	1-3
1.5.1.5	Specialized Designs	1-3
1.5.1.6	Should	1-3
1.6	Process Control Methodologies	1-3
1.7	Order of Precedence	1-4
1.7.1	Clause References	1-4
1.7.2	Appendices	1-4
1.8	Terms and Definitions	1-4
1.8.1	Board Orientation	1-4
1.8.1.1	Primary Side	1-4
1.8.1.2	Secondary Side	1-4
1.8.1.3	Solder Source Side	1-4
1.8.1.4	Solder Destination Side	1-4
1.8.2	Bubble	1-4
1.8.2.1	Bridging Bubble	1-4
1.8.3	Cold Solder Connection	1-4
1.8.4	Common Conductors	1-4
1.8.5	Conductor Overlap	1-4
1.8.6	Conductor Overwrap	1-4
1.8.7	Diameter	1-5
1.8.8	Electrical Clearance	1-5
1.8.9	Engineering Documentation	1-5
1.8.10	FOD (Foreign Object Debris)	1-5
1.8.11	Form, Fit, Function (F/F/F)	1-5
1.8.12	High Voltage	1-5
1.8.13	Intrusive Solder	1-5
1.8.14	Kink	1-5

1.8.15	Locking Mechanism	1-5
1.8.16	Manufacturer	1-5
1.8.17	Meniscus (Component)	1-5
1.8.18	Noncommon Conductors	1-5
1.8.19	Nonfunctional Land	1-5
1.8.20	Pin-in-Paste	1-5
1.8.21	Solder Balls	1-5
1.8.22	Standard Industry Practice (SIP)	1-5
1.8.23	Stress Relief	1-6
1.8.24	Supplier	1-6
1.8.25	Tempered Leads	1-6
1.8.26	User	1-6
1.9	Requirements Flowdown	1-6
1.10	Personnel Proficiency	1-6
1.11	Acceptance Requirements	1-6
1.11.1	Missing Parts and Components	1-6
1.11.2	Jumper Wire or Z-Wire	1-6
1.12	Minimum Electrical Clearance (MEC)	1-7
1.13	Inspection Methodology	1-9
1.13.1	Lighting	1-9
1.13.2	Magnification Aids	1-9
2.0	Applicable Documents	2-1
2.1	IPC Documents	2-1
2.2	Joint Industry Documents	2-2
2.3	Electrostatic Association Documents	2-2
2.4	International Electrotechnical Commission Documents	2-2
2.5	ASTM	2-2
2.6	Military Standards	2-3
2.7	SAE International	2-3
3.0	Handling Electronic Assemblies	3-1
4.0	Hardware	4-1
4.1	Hardware Installation	4-2
4.1.1	Hardware Installation — Electrical Clearance	4-2
4.1.2	Hardware Installation — Interference	4-3
4.1.3	Hardware Installation — Component Mounting — High Power	4-4
4.1.4	Hardware Installation — Heatsinks	4-6
4.1.4.1	Hardware Installation — Heatsinks — Insulators and Thermal Compounds	4-6
4.1.4.2	Hardware Installation — Heatsinks — Contact	4-7
4.1.5	Hardware Installation — Threaded Fasteners and Other Threaded Hardware	4-8
4.1.5.1	Hardware Installation — Threaded Fasteners and Other Threaded Hardware — Torque	4-10

4.1.5.2	Hardware Installation — Threaded Fasteners and Other Threaded Hardware – Solid Wires	4-12
4.1.5.3	Hardware Installation — Threaded Fasteners and Other Threaded Hardware – Stranded Wires.....	4-14
4.2	Jackpost Mounting	4-15
4.3	Connector Pins	4-16
4.3.1	Connector Pins — Edge Connector Pins.....	4-16
4.3.2	Connector Pins — Press Fit Pins.....	4-16
4.3.2.1	Connector Pins — Press Fit Pins – Land/Annular Ring	4-18
4.3.2.2	Connector Pins — Press Fit Pins – Soldering.....	4-19
4.4	Wire Bundle Securing.....	4-20
4.5	Routing — Wires and Wire Bundles	4-20
5.0	Soldering	5-1
5.1	Soldering Acceptability Requirements.....	5-2
5.2	Soldering Anomalies	5-3
5.2.1	Soldering Anomalies — Exposed Basis Metal.....	5-3
5.2.2	Soldering Anomalies — Pin Holes/Blow Holes/Voids.....	5-5
5.2.3	Soldering Anomalies — Reflow of Solder Paste.....	5-6
5.2.4	Soldering Anomalies — Nonwetting.....	5-7
5.2.5	Soldering Anomalies — Cold Connection	5-8
5.2.6	Soldering Anomalies — Dewetting.....	5-8
5.2.7	Soldering Anomalies — Excess Solder	5-9
5.2.7.1	Soldering Anomalies — Excess Solder – Solder Balls	5-10
5.2.7.2	Soldering Anomalies — Excess Solder – Bridging.....	5-11
5.2.7.3	Soldering Anomalies — Excess Solder – Solder Webbing/Splashes	5-12
5.2.8	Soldering Anomalies — Disturbed Solder	5-13
5.2.9	Soldering Anomalies — Cooling Lines and Secondary Reflow	5-14
5.2.10	Soldering Anomalies — Fractured Solder	5-15
5.2.11	Soldering Anomalies — Solder Projections.....	5-16
5.2.12	Soldering Anomalies — Pb-Free Fillet Lift.....	5-17
5.2.13	Soldering Anomalies — Pb-Free Hot Tear/Shrink Hole	5-18
5.2.14	Probe Marks and Other Similar Surface Conditions in Solder Joints.....	5-19
5.2.15	Inclusions.....	5-20
5.3	Partially Visible or Hidden Solder Connections	5-20
5.4	Heat Shrinkable Soldering Devices	5-21
6.0	Terminal Connections.....	6-1
6.1	Swaged Hardware	6-2
6.1.1	Swaged Hardware — Terminals	6-2
6.1.1.1	Swaged Hardware — Terminals – Terminal Base to Land Separation	6-2
6.1.1.2	Swaged Hardware — Terminals – Turret	6-4
6.1.1.3	Swaged Hardware — Terminals – Bifurcated	6-5
6.1.2	Swaged Hardware — Rolled Flange.....	6-6

6.1.3	Swaged Hardware — Flared Flange	6-7
6.1.4	Swaged Hardware — Controlled Split	6-8
6.1.5	Swaged Hardware — Solder	6-9
6.2	Insulation	6-11
6.2.1	Insulation — Damage	6-11
6.2.1.1	Insulation — Damage – Presolder	6-11
6.2.1.2	Insulation — Damage – Post-Solder	6-13
6.2.2	Insulation — Clearance	6-14
6.2.3	Insulation — Insulation Sleeving	6-16
6.2.3.1	Insulation — Insulation Sleeving – Placement	6-16
6.2.3.2	Insulation — Insulation Sleeving – Damage	6-18
6.3	Conductor	6-19
6.3.1	Conductor — Deformation	6-19
6.3.2	Conductor — Damage	6-20
6.3.2.1	Conductor — Damage – Stranded Wire	6-20
6.3.2.2	Conductor — Damage – Solid Wire	6-21
6.3.3	Conductor — Strand Separation (Birdcaging) – Presolder	6-21
6.3.4	Conductor — Strand Separation (Birdcaging) – Post-Solder	6-22
6.3.5	Conductor — Tinning	6-23
6.4	Service Loops	6-25
6.5	Routing — Wires and Wire Bundles – Bend Radius	6-26
6.6	Stress Relief	6-27
6.6.1	Stress Relief — Wire	6-27
6.7	Lead/Conductor Placement — General Requirements	6-29
6.8	Solder — General Requirements	6-30
6.9	Turrets and Straight Pins	6-32
6.9.1	Turrets and Straight Pins — Conductor Placement	6-32
6.9.2	Turrets and Straight Pins — Solder	6-34
6.10	Bifurcated	6-35
6.10.1	Bifurcated — Conductor Placement – Side Route Attachments	6-35
6.10.2	Bifurcated — Conductor Placement – Staked Wires	6-37
6.10.3	Bifurcated — Conductor Placement – Bottom and Top Route Attachments	6-38
6.10.4	Bifurcated — Solder	6-39
6.11	Slotted	6-41
6.11.1	Slotted — Conductor Placement	6-41
6.11.2	Slotted — Solder	6-42
6.12	Pierced/Perforated	6-43
6.12.1	Pierced/Perforated — Conductor Placement	6-43
6.12.2	Pierced/Perforated — Solder	6-45
6.13	Hook	6-46
6.13.1	Hook — Conductor Placement	6-46

6.13.2	Hook — Solder	6-48
6.14	Solder Cups	6-49
6.14.1	Solder Cups — Conductor Placement	6-49
6.14.2	Solder Cups — Solder	6-50
6.15	AWG 30 and Smaller Diameter Wires — Conductor Placement	6-52
6.16	Series Connected	6-54
6.17	Edge Clip — Position	6-55
7.0	Through-Hole Technology	7-1
7.1	Component Mounting	7-1
7.1.1	Component Mounting — Orientation	7-1
7.1.1.1	Component Mounting — Orientation – Horizontal	7-2
7.1.1.2	Component Mounting — Orientation – Vertical	7-3
7.1.2	Component Mounting — Lead Forming	7-4
7.1.2.1	Component Mounting — Lead Forming – Bend Radius	7-4
7.1.2.2	Component Mounting — Lead Forming – Space between Seal/Weld and Bend	7-5
7.1.2.3	Component Mounting — Lead Forming – Stress Relief	7-6
7.1.2.4	Component Mounting — Lead Forming – Damage	7-8
7.1.3	Component Mounting — Leads Crossing Conductors	7-9
7.1.4	Component Mounting — Hole Obstruction	7-10
7.1.5	Component Mounting — DIP/SIP Devices and Sockets	7-11
7.1.6	Component Mounting — Radial Leads – Vertical	7-13
7.1.6.1	Component Mounting — Radial Leads – Vertical – Spacers	7-14
7.1.7	Component Mounting — Radial Leads – Horizontal	7-15
7.1.8	Component Mounting — Connectors	7-16
7.1.8.1	Component Mounting — Connectors – Right Angle	7-17
7.1.8.2	Component Mounting — Connectors – Vertical Shrouded Pin Headers and Vertical Receptacle Connectors	7-18
7.2	Component Securing	7-19
7.2.1	Component Securing — Mounting Clips	7-19
7.2.2	Component Securing — Adhesive Bonding	7-20
7.2.2.1	Component Securing — Adhesive Bonding – Nonelevated Components	7-21
7.2.2.2	Component Securing — Adhesive Bonding – Elevated Components	7-24
7.2.3	Component Securing — Other Devices	7-27
7.3	Supported Holes	7-28
7.3.1	Supported Holes — Axial Loaded – Horizontal	7-28
7.3.2	Supported Holes — Axial Loaded – Vertical	7-29
7.3.3	Supported Holes — Leads/Conductors Protrusion	7-31
7.3.4	Supported Holes — Lead/Conductor Clinches	7-32
7.3.5	Supported Holes — Solder	7-33
7.3.5.1	Supported Holes — Solder – Vertical Fill (A)	7-36
7.3.5.2	Supported Holes — Solder – Solder Destination Side – Lead to Barrel (B)	7-38

7.3.5.3	Supported Holes — Solder – Solder Destination Side – Land Area Coverage (C).....	7-40
7.3.5.4	Supported Holes — Solder – Solder Source Side – Lead to Barrel (D)	7-41
7.3.5.5	Supported Holes — Solder – Solder Source Side – Land Area Coverage (E).....	7-42
7.3.5.6	Supported Holes — Solder Conditions – Solder in Lead Bend.....	7-43
7.3.5.7	Supported Holes — Solder Conditions – Touching Through-Hole Component Body	7-44
7.3.5.8	Supported Holes — Solder Conditions – Meniscus in Solder	7-45
7.3.5.9	Supported Holes — Lead Cutting After Soldering.....	7-47
7.3.5.10	Supported Holes — Coated Wire Insulation in Solder.....	7-48
7.3.5.11	Supported Holes — Interfacial Connection without Lead – Vias.....	7-49
7.3.5.12	Supported Holes — Board in Board	7-50
7.4	Unsupported Holes	7-53
7.4.1	Unsupported Holes — Axial Leads – Horizontal	7-53
7.4.2	Unsupported Holes — Axial Leads – Vertical	7-54
7.4.3	Unsupported Holes — Wire/Lead Protrusion.....	7-55
7.4.4	Unsupported Holes — Wire/Lead Clinches.....	7-56
7.4.5	Unsupported Holes — Solder.....	7-58
7.4.6	Unsupported Holes — Lead Cutting After Soldering.....	7-60
8.0	Surface Mount Assemblies	8-1
8.1	Staking Adhesive.....	8-2
8.1.1	Staking Adhesive — Component Bonding.....	8-2
8.1.2	Staking Adhesive — Mechanical Strength.....	8-3
8.2	SMT Leads	8-5
8.2.1	SMT Leads — Plastic Components.....	8-5
8.2.2	SMT Leads — Damage	8-5
8.2.3	SMT Leads — Flattening	8-6
8.3	SMT Connections	8-6
8.3.1	Chip Components — Bottom Only Terminations.....	8-7
8.3.1.1	Chip Components — Bottom Only Terminations – Side Overhang (A).....	8-8
8.3.1.2	Chip Components — Bottom Only Terminations – End Overhang (B)	8-9
8.3.1.3	Chip Components — Bottom Only Terminations – End Joint Width (C)	8-10
8.3.1.4	Chip Components — Bottom Only Terminations – Side Joint Length (D).....	8-11
8.3.1.5	Chip Components — Bottom Only Terminations – Maximum Fillet Height (E).....	8-12
8.3.1.6	Chip Components — Bottom Only Terminations – Minimum Fillet Height (F)	8-12
8.3.1.7	Chip Components — Bottom Only Terminations – Solder Thickness (G)	8-13
8.3.1.8	Chip Components — Bottom Only Terminations – End Overlap (J).....	8-13
8.3.2	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s)	8-14
8.3.2.1	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Side Overhang (A)	8-15
8.3.2.2	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – End Overhang (B).....	8-17

8.3.2.3	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – End Joint Width (C)	8-18
8.3.2.4	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Side Joint Length (D)	8-20
8.3.2.5	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Maximum Fillet Height (E)	8-21
8.3.2.6	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Minimum Fillet Height (F).....	8-22
8.3.2.7	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Solder Thickness (G).....	8-23
8.3.2.8	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – End Overlap (J).....	8-24
8.3.2.9	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Termination Variations	8-25
8.3.2.9.1	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Termination Variations – Mounting on Side (Billboarding)	8-25
8.3.2.9.2	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Termination Variations – Mounting Upside Down.....	8-27
8.3.2.9.3	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Termination Variations – Stacking	8-28
8.3.2.9.4	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Termination Variations – Tombstoning.....	8-29
8.3.2.10	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Center and Lateral Terminations	8-30
8.3.2.10.1	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Center and Lateral Terminations – Solder Width of Side Termination	8-31
8.3.2.10.2	Rectangular or Square End Chip Components — 1, 2, 3 or 5 Side Termination(s) – Center and Lateral Terminations – Minimum Fillet Height of Side Termination.....	8-32
8.3.3	Cylindrical End Cap Terminations	8-33
8.3.3.1	Cylindrical End Cap Terminations — Side Overhang (A).....	8-34
8.3.3.2	Cylindrical End Cap Terminations — End Overhang (B)	8-35
8.3.3.3	Cylindrical End Cap Terminations — End Joint Width (C)	8-36
8.3.3.4	Cylindrical End Cap Terminations — Side Joint Length (D).....	8-37
8.3.3.5	Cylindrical End Cap Terminations — Maximum Fillet Height (E).....	8-38
8.3.3.6	Cylindrical End Cap Terminations — Minimum Fillet Height (F)	8-39
8.3.3.7	Cylindrical End Cap Terminations — Solder Thickness (G)	8-40
8.3.3.8	Cylindrical End Cap Terminations — End Overlap (J)	8-41
8.3.3.9	Cylindrical End Cap Terminations — Center and Lateral Terminations.....	8-42
8.3.4	Castellated Terminations	8-43
8.3.4.1	Castellated Terminations — Side Overhang (A).....	8-44
8.3.4.2	Castellated Terminations — End Overhang (B)	8-45
8.3.4.3	Castellated Terminations — Minimum End Joint Width (C)	8-45
8.3.4.4	Castellated Terminations — Minimum Side Joint Length (D).....	8-46

8.3.4.5	Castellated Terminations — Maximum Fillet Height (E).....	8-46
8.3.4.6	Castellated Terminations — Minimum Fillet Height (F)	8-47
8.3.4.7	Castellated Terminations — Solder Thickness (G)	8-47
8.3.5	Flat Gull Wing Leads.....	8-48
8.3.5.1	Flat Gull Wing Leads — Side Overhang (A)	8-49
8.3.5.2	Flat Gull Wing Leads — Toe Overhang (B)	8-52
8.3.5.3	Flat Gull Wing Leads — Minimum End Joint Width (C).....	8-53
8.3.5.4	Flat Gull Wing Leads — Minimum Side Joint Length (D).....	8-54
8.3.5.5	Flat Gull Wing Leads — Maximum Heel Fillet Height (E)	8-55
8.3.5.6	Flat Gull Wing Leads — Minimum Heel Fillet Height (F).....	8-56
8.3.5.7	Flat Gull Wing Leads — Solder Thickness (G).....	8-57
8.3.5.8	Flat Gull Wing Leads — Coplanarity	8-58
8.3.6	Round or Flattened (Coined) Gull Wing Leads	8-59
8.3.6.1	Round or Flattened (Coined) Gull Wing Leads — Side Overhang (A).....	8-60
8.3.6.2	Round or Flattened (Coined) Gull Wing Leads — Toe Overhang (B).....	8-61
8.3.6.3	Round or Flattened (Coined) Gull Wing Leads — Minimum End Joint Width (C)	8-61
8.3.6.4	Round or Flattened (Coined) Gull Wing Leads — Minimum Side Joint Length (D)	8-62
8.3.6.5	Round or Flattened (Coined) Gull Wing Leads — Maximum Heel Fillet Height (E).....	8-63
8.3.6.6	Round or Flattened (Coined) Gull Wing Leads — Minimum Heel Fillet Height (F)	8-64
8.3.6.7	Round or Flattened (Coined) Gull Wing Leads — Solder Thickness (G)	8-65
8.3.6.8	Round or Flattened (Coined) Gull Wing Leads — Minimum Side Joint Height (Q).....	8-65
8.3.6.9	Round or Flattened (Coined) Gull Wing Leads — Coplanarity	8-66
8.3.7	J Leads.....	8-67
8.3.7.1	J Leads — Side Overhang (A)	8-67
8.3.7.2	J Leads — Toe Overhang (B)	8-69
8.3.7.3	J Leads — End Joint Width (C)	8-70
8.3.7.4	J Leads — Side Joint Length (D)	8-71
8.3.7.5	J Leads — Maximum Heel Fillet Height (E)	8-72
8.3.7.6	J Leads — Minimum Heel Fillet Height (F).....	8-73
8.3.7.7	J Leads — Solder Thickness (G).....	8-75
8.3.7.8	J Leads — Coplanarity	8-75
8.3.8	Butt/I Connections	8-76
8.3.8.1	Butt/I Connections — Modified Through-Hole Terminations	8-76
8.3.8.1.1	Butt/I Connections — Modified Through-Hole Terminations – Maximum Side Overhang (A)	8-77
8.3.8.1.2	Butt/I Connections — Modified Through-Hole Terminations – Toe Overhang (B)	8-77
8.3.8.1.3	Butt/I Connections — Modified Through-Hole Terminations – Minimum End Joint Width (C).....	8-78
8.3.8.1.4	Butt/I Connections — Modified Through-Hole Terminations – Minimum Side Joint Length (D).....	8-78
8.3.8.1.5	Butt/I Connections — Modified Through-Hole Terminations – Maximum Fillet Height (E).....	8-78
8.3.8.1.6	Butt/I Connections — Modified Through-Hole Terminations – Minimum Fillet Height (F).....	8-79
8.3.8.1.7	Butt/I Connections — Modified Through-Hole Terminations – Solder Thickness (G).....	8-79
8.3.8.2	Butt/I Connections — Solder Charged Terminations	8-80

8.3.8.2.1	Butt/I Connections — Solder Charged Terminations – Maximum Side Overhang (A)	8-81
8.3.8.2.2	Butt/I Connections — Solder Charged Terminations – Maximum Toe Overhang (B)	8-81
8.3.8.2.3	Butt/I Connections — Solder Charged Terminations – Minimum End Joint Width (C).....	8-82
8.3.8.2.4	Butt/I Connections — Solder Charged Terminations – Minimum Fillet Height (F).....	8-82
8.3.9	Flat Lug Leads	8-83
8.3.10	Tall Profile Components Having Bottom Only Terminations.....	8-84
8.3.11	Inward Formed L-Shaped Ribbon Leads	8-85
8.3.12	Surface Mount Area Array	8-87
8.3.12.1	Surface Mount Area Array — Alignment	8-88
8.3.12.2	Surface Mount Area Array — Solder Ball Spacing.....	8-88
8.3.12.3	Surface Mount Area Array — Solder Connections	8-89
8.3.12.4	Surface Mount Area Array — Voids	8-91
8.3.12.5	Surface Mount Area Array — Underfill/Staking.....	8-91
8.3.12.6	Surface Mount Area Array — Package on Package	8-92
8.3.13	Bottom Termination Components (BTC)	8-94
8.3.14	Components with Bottom Thermal Pad Terminations (D-Pak).....	8-96
8.3.15	Flattened Post Connections	8-98
8.3.15.1	Flattened Post Connections — Maximum Termination Overhang – Square Solder Land.....	8-98
8.3.15.2	Flattened Post Connections — Maximum Termination Overhang – Round Solder Land.....	8-99
8.3.15.3	Flattened Post Connections — Maximum Fillet Height.....	8-99
8.3.16	P-Style Terminations	8-100
8.3.16.1	P-Style Terminations — Maximum Side Overhang (A).....	8-101
8.3.16.2	P-Style Terminations — Maximum Toe Overhang (B)	8-101
8.3.16.3	P-Style Terminations — Minimum End Joint Width (C)	8-102
8.3.16.4	P-Style Terminations — Minimum Side Joint Length (D).....	8-102
8.3.16.5	P-Style Terminations — Minimum Fillet Height (F)	8-103
8.3.17	Vertical Cylindrical Cans with Outward L-Shaped Lead Terminations.....	8-104
8.3.18	Flexible and Rigid Flex Printed Circuitry with Flat Uniformed Leads	8-106
8.3.19	Wrapped Terminals.....	8-107
8.3.19.1	Wrapped Terminals — Side Overhang (A)	8-108
8.3.19.2	Wrapped Terminals — End Joint Width (C)	8-108
8.3.19.3	Wrapped Terminals — Side Joint Length (D).....	8-108
8.3.19.4	Wrapped Terminals — Minimum Heel Fillet Height (F)	8-109
8.3.19.5	Wrapped Terminals — Solder Thickness (G).....	8-109
8.3.20	Flat Ledged Surface Mount Connectors.....	8-110
8.4	Specialized SMT Terminations.....	8-111
8.5	Surface Mount Connectors	8-112
8.5.1	Surface Mount Connectors — Surface Mount Threaded Standoffs (SMTS) or Surface Mount Fasteners... ..	8-113
9.0	Component Damage	9-1
9.1	Loss of Metallization.....	9-2

9.2	Chip Resistor Element	9-3
9.3	Leaded/Leadless Devices	9-4
9.4	Ceramic Chip Capacitors	9-8
9.5	Connectors	9-10
9.6	Relays	9-13
9.7	Ferrite Core Components	9-13
9.8	Connectors, Handles, Extractors, Latches	9-14
9.9	Edge Connector Pins	9-15
9.10	Press Fit Pins	9-16
9.11	Backplane Connector Pins	9-17
9.12	Heatsink Hardware	9-18
9.13	Threaded Items and Hardware	9-19
10.0	Printed Boards and Assemblies	10-1
10.1	Non-Soldered Contact Areas	10-1
10.1.1	Non-Soldered Contact Area — Contamination	10-1
10.1.2	Non-Soldered Contact Area — Damage	10-3
10.2	Laminate Conditions	10-3
10.2.1	Laminate Conditions — Measling and Cracking	10-5
10.2.2	Laminate Conditions — Blistering and Delamination	10-7
10.2.3	Laminate Conditions — Weave Texture/Weave Exposure	10-10
10.2.4	Laminate Conditions — Haloing	10-11
10.2.5	Laminate Conditions — Nicks and Cracks	10-13
10.2.6	Laminate Conditions — Burns	10-15
10.2.7	Laminate Conditions — Bow and Twist	10-16
10.2.8	Laminate Conditions — Depanelization	10-17
10.2.9	Laminate Conditions — Mechanical Damage	10-19
10.3	Conductors/Lands	10-20
10.3.1	Conductors/Lands — Reduction	10-20
10.3.2	Conductors/Lands — Lifted	10-21
10.3.3	Conductors/Lands — Mechanical Damage	10-23
10.4	Flexible and Rigid-Flex Printed Boards	10-24
10.4.1	Flexible and Rigid-Flex Printed Boards — Damage	10-24
10.4.2	Flexible and Rigid-Flex Printed Boards — Delamination/Blister	10-27
10.4.2.1	Flexible and Rigid-Flex Printed Boards — Delamination/Blister — Flex	10-27
10.4.2.2	Flexible and Rigid-Flex Printed Boards — Delamination/Blister — Flex to Stiffener	10-29
10.4.3	Flexible and Rigid-Flex Printed Boards — Solder Wicking	10-30
10.4.4	Flexible and Rigid-Flex Printed Boards — Attachment	10-31
10.5	Marking	10-32
10.5.1	Marking — Etched (Including Hand Printing)	10-34
10.5.2	Marking — Screened	10-35

10.5.3	Marking — Stamped	10-36
10.5.4	Marking — Laser	10-37
10.5.5	Marking — Labels	10-37
10.5.5.1	Marking — Labels – Bar Coding/Data Matrix	10-37
10.5.5.2	Marking — Labels – Readability	10-38
10.5.5.3	Marking — Labels – Adhesion and Damage	10-39
10.5.5.4	Marking — Labels – Position	10-39
10.5.6	Marking — Radio Frequency Identification (RFID) Tags	10-40
10.6	Cleanliness	10-41
10.6.1	Cleanliness — Flux Residues	10-42
10.6.1.1	Cleanliness — Flux Residues – Cleaning Required	10-42
10.6.1.2	Cleanliness — Flux Residues – No Clean Process	10-43
10.6.2	Cleanliness — Foreign Object Debris (FOD)	10-44
10.6.3	Cleanliness — Chlorides, Carbonates and White Residues	10-45
10.6.4	Cleanliness — Surface Appearance	10-47
10.7	Solder Mask Coating	10-48
10.7.1	Solder Mask Coating — Wrinkling/Cracking	10-49
10.7.2	Solder Mask Coating — Voids, Blisters, Scratches	10-51
10.7.3	Solder Mask Coating — Breakdown	10-53
10.7.4	Solder Mask Coating — Discoloration	10-54
10.8	Conformal Coating	10-54
10.8.1	Conformal Coating — General	10-54
10.8.2	Conformal Coating — Coverage	10-55
10.8.3	Conformal Coating — Thickness	10-57
10.9	Electrical Insulation Coating	10-58
10.9.1	Electrical Insulation Coating — Coverage	10-58
10.9.2	Electrical Insulation Coating — Thickness	10-58
10.10	Encapsulation	10-59
11.0	Discrete Wiring	11-1
11.1	Solderless Wrap	11-1
12.0	High Voltage	12-1
13.0	Jumper Wires	13-1
13.1	Wire Routing	13-2
13.2	Wire Staking — Adhesive or Tape	13-3
13.3	Terminations	13-4
13.3.1	Terminations — Lap	13-5
13.3.1.1	Terminations — Lap – Component Lead	13-5
13.3.1.2	Terminations — Lap – Land	13-7
13.3.2	Terminations — Wire in Hole	13-8
13.3.3	Terminations — Wrapped	13-9

13.3.4	Terminations — SMT	13-10
13.3.4.1	Terminations — SMT – Chip and Cylindrical End Cap Components	13-10
13.3.4.2	Terminations — SMT – Gull Wing	13-11
13.3.4.3	Terminations — SMT – Castellations	13-13

Tables

Table 1-1	Summary of Related Documents	1-1
Table 1-2	Inspection Magnification (Land Width)	1-9
Table 1-3	Magnification Aid Applications For Wires And Soldered Conductors	1-10
Table 1-4	Magnification Aid Applications – Other	1-10
Table 6-1	Swaged Hardware Minimum Soldering Requirements	6-9
Table 6-2	Strand Damage	6-20
Table 6-3	Minimum Bend Radius Requirements	6-26
Table 6-4	Turret or Straight Pin Terminal Conductor Placement	6-32
Table 6-5	Bifurcated Terminal Conductor Placement – Side Route	6-35
Table 6-6	Staking Requirements of Side Route Straight Through Connections – Bifurcated Terminals	6-37
Table 6-7	Bifurcated Terminal Conductor Placement – Bottom Route	6-38
Table 6-8	Pierced or Perforated Terminal Conductor Placement	6-43
Table 6-9	Hook Terminal Conductor Placement	6-46
Table 6-10	AWG 30 and Smaller Wire Wrap Requirements	6-52
Table 7-1	Lead Bend Radius	7-4
Table 7-2	Component to Land Clearance	7-29
Table 7-3	Protrusion of Leads/Conductors in Supported Holes	7-31
Table 7-4	Supported Hole – Minimum Solder Requirements	7-35
Table 7-5	Board in Board – Minimum Acceptable Solder Conditions	7-50
Table 7-6	Protrusion of Leads in Unsupported Holes	7-55
Table 7-7	Unsupported Holes with Component Leads, Minimum Acceptable Conditions	7-58
Table 8-1	Dimensional Criteria – Chip Component – Bottom Only Termination Features	8-7
Table 8-2	Dimensional Criteria – Rectangular or Square End Chip Components – 1, 2, 3 or 5 Side Termination(s)	8-14
Table 8-2A	Dimensional Criteria – Center/Lateral Termination (When Present) – Rectangular or Square End Chip Components – 1, 2, 3 or 5 Side Termination(s)	8-30
Table 8-3	Dimensional Criteria – Cylindrical End Cap Termination	8-33
Table 8-3A	Dimensional Criteria – Cylindrical End Cap Terminations – Center and Lateral Terminations	8-42
Table 8-4	Dimensional Criteria – Castellated Terminations	8-43
Table 8-5	Dimensional Criteria – Flat Gull Wing Leads	8-48
Table 8-6	Dimensional Criteria – Round or Flattened (Coined) Gull Wing Lead Features	8-59
Table 8-7	Dimensional Criteria – J Leads	8-67
Table 8-8	Dimensional Criteria – Butt/I Connections – Modified Through-Hole Leads	8-76
Table 8-9	Dimensional Criteria – Butt/I Connections – Solder Charged Terminations	8-80
Table 8-10	Dimensional Criteria – Flat Lug Leads	8-83
Table 8-11	Dimensional Criteria – Tall Profile Components Having Bottom Only Terminations	8-84

Table 8-12	Dimensional Criteria – Inward Formed L-Shaped Ribbon Leads	8-85
Table 8-13	Dimensional Criteria – Ball Grid Array Components with Collapsing Balls.....	8-87
Table 8-14	Ball Grid Array Components with Noncollapsing Balls.....	8-87
Table 8-15	Column Grid Array.....	8-87
Table 8-16	Dimensional Criteria – BTC	8-94
Table 8-17	Dimensional Criteria – Bottom Thermal Pad Terminations (D-Pak)	8-96
Table 8-18	Dimensional Criteria Flattened Post Connections	8-98
Table 8-19	Dimensional Criteria – P-Style Terminations	8-100
Table 8-20	Dimensional Criteria – Vertical Cylindrical Cans with Outward L-Shaped Lead Terminations	8-105
Table 8-21	Dimensional Criteria – Flexible and Rigid-Flex Circuitry with Flat Unformed Leads.....	8-106
Table 8-22	Dimensional Criteria – Wrapped Terminals.....	8-107
Table 8-23	Dimensional Criteria – Flat Ledged Surface Mount Connectors	8-110
Table 8-24	SMTS/Surface Mount Fasteners – Minimum Acceptable Solder Conditions	8-113
Table 9-1	Nick or Chip-Out Criteria	9-8
Table 10-1	Coating Thickness Requirements	10-57
Table A-1	Typical Static Charge Sources	A-3
Table A-2	Typical Static Voltage Generation.....	A-3
Table A-3	Recommended Practices for Handling Electronic Assemblies.....	A-6
Appendix A	Protecting the Assembly – ESD and Other Handling Considerations	A-1
A.1	ESD Prevention	A-1
A.1.1	ESD Control Program.....	A-1
A.1.2	ESD Protective Area (EPA) Requirements.....	A-2
A.1.3	Minimizing Static Charge	A-3
A.1.4	ESD Protective Packaging	A-4
A.1.5	Training.....	A-4
A.1.6	Tools And Equipment	A-4
A.1.7	Compliance Verification.....	A-5
A.1.8	ESD Prevention – Warning Labels.....	A-5
A.2	General Handling.....	A-6
A.2.1	Handling Considerations	A-6
A.2.2	Preventing Contamination.....	A-7
A.2.3	Handling Considerations – Gloves and Finger Cots	A-7
A.3	Moisture Sensitive Devices	A-8
Index	Index-1

This Page Intentionally Left Blank

1.0 General

1.1 Scope This standard is a collection of visual quality acceptability requirements for electronic assemblies. This standard does not provide criteria for cross-section evaluation or x-ray inspection. There are x-ray guidelines located in J-STD-001.

This document presents acceptance requirements for the manufacture of electrical and electronic assemblies. Historically, electronic assembly standards contained a more comprehensive tutorial addressing principles and techniques. For a more complete understanding of this document's recommendations and requirements, one may use this document in conjunction with IPC-HDBK-001 or IPC-AJ-820.

The criteria in this standard are not intended to define processes to accomplish assembly operations nor is it intended to authorize repair/modification or change of the product. For instance, the presence of criteria for adhesive bonding of components does not imply/authorize/require the use of adhesive bonding and the depiction of a leads/conductors wrapped clockwise around a terminal does not imply/authorize/require that all leads/conductors be wrapped in the clockwise direction.

Users of this standard should be knowledgeable of the applicable requirements of the document and how to apply them, see 1.3 Classification.

IPC-A-610 has criteria outside the scope of J-STD-001 defining mechanical and other workmanship requirements. Table 1-1 is a summary of related IPC documents that the user may want to be familiar with to better understand the requirements of this document. For additional referenced documents see section 2.0 Applicable Documents.

Table 1-1 Summary of Related Documents

Document Purpose	Spec.#	Definition
Design Standard	IPC-222X IPC-7351 IPC-CM-770	Design requirements reflecting three levels of complexity (Levels A, B, and C) indicating finer geometries, greater densities, more process steps to produce the product. Component and Assembly Process Guidelines to assist in the design of the bare board and the assembly where the bare board processes concentrate on land patterns for surface mount and the assembly concentrates on surface mount and through-hole principles which are usually incorporated into the design process and the documentation.
Printed Board – Requirements	IPC-601X IPC-A-600	Requirements and acceptance documentation for rigid, rigid flex, flex and other types of substrates.
Process Requirement Standard	J-STD-001	Requirements for soldered electrical and electronic assemblies depicting minimum end product acceptable characteristics as well as methods for evaluation (test methods), frequency of testing and applicable ability of process control requirements.
Acceptability Standard	IPC-A-610	Pictorial interpretive document indicating various characteristics of the board and/or assembly as appropriate relating to desirable conditions that exceed the minimum acceptable characteristics indicated by the end item performance standard and reflect various out-of-control (process indicator or defect) conditions to assist the shop process evaluators in judging need for corrective action.
Training Programs (Optional)		Documented training for process, procedures, techniques and requirements.
Rework and Repair	IPC-7711/7721	Documentation providing the procedures to accomplish conformal coating and component removal and replacement, solder resist repair, and modification/repair of laminate material, conductors, and PTHs (plated through-holes).
Assembly and Joining Handbook	IPC-AJ-820	IPC-AJ-820 is a supporting document that provides information regarding the intent of this specification content and explains or amplifies the technical rationale for transition of limits through Acceptable to Defect condition criteria. In addition, supporting information is provided to give a broader understanding of the process considerations that are related to performance but not commonly distinguishable through visual assessment methods The explanations provided in IPC-AJ-820 should be useful in determining disposition of conditions identified as Defect, processes associated with Process Indicators, as well as answering questions regarding clarification in use and application for defined content of this specification. Contractual reference to IPC-A-610 does not additionally impose the content of IPC-AJ-820 unless specifically referenced in contractual documentation.

1.2 Purpose The visual standards in this document reflect the requirements of existing IPC and other applicable specifications. For the content of this document to apply, the assembly/product should comply with other existing IPC requirements, such as IPC-7351, IPC-222X (where X is the last digit in the IPC document number), IPC-601X and IPC-A-600. If the assembly does not comply with these or with equivalent requirements, the acceptance criteria **shall** be defined between the User and Supplier.